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Non-destructive testing - Characterization and verification of ultrasonic test equipment - Part 2: Probes (ISO 22232-2:2020)

Contents		Page
European foreword		4
Foreword		5
1	Scope	6
2	Normative references	6
3	Terms and definitions	6
4	Symbols	8
5	General requirements of conformity	9
6	Technical information for probes	10
6.1	General.....	10
6.2	Probe data sheet.....	10
6.3	Probe test report.....	10
7	Test equipment	12
7.1	Electronic equipment.....	12
7.2	Test blocks and other equipment.....	12
8	Performance requirements for probes	20
8.1	Physical aspects.....	20
8.1.1	Procedure.....	20
8.1.2	Acceptance criterion.....	20
8.2	Pulse shape, amplitude and duration.....	20
8.2.1	Procedure.....	20
8.2.2	Acceptance criterion.....	21
8.3	Frequency spectrum and bandwidth.....	22
8.3.1	Procedure.....	22
8.3.2	Acceptance criteria.....	22
8.4	Pulse-echo sensitivity.....	22
8.4.1	Procedure.....	22
8.4.2	Acceptance criterion.....	23
8.5	Distance-amplitude curve.....	23
8.5.1	General.....	23
8.5.2	Procedure.....	23
8.5.3	Acceptance criterion.....	25
8.6	Beam parameters for immersion probes.....	25
8.6.1	General.....	25
8.6.2	Beam profile — Measurements performed directly on the beam.....	26
8.6.3	Beam profile — Measurements made using an automated scanning system.....	33
8.7	Beam parameters for straight-beam single-transducer contact probes.....	35
8.7.1	General.....	35
8.7.2	Beam divergence and side lobes.....	36
8.7.3	Squint angle and offset for straight-beam probes.....	37
8.7.4	Focal distance (near field length).....	38
8.7.5	Focal width.....	38
8.7.6	Length of the focal zone.....	39
8.8	Beam parameters for angle-beam single-transducer contact probes.....	39
8.8.1	General.....	39
8.8.2	Index point.....	39

8.8.3	Beam angle and beam divergence.....	40
8.8.4	Squint angle and offset for angle-beam probes.....	43
8.8.5	Focal distance (near field length).....	46
8.8.6	Focal width.....	47
8.8.7	Length of the focal zone.....	47
8.9	Beam parameters for straight-beam dual-transducer contact probes.....	48
8.9.1	General.....	48
8.9.2	Delay line delay path.....	48
8.9.3	Focal distance.....	48
8.9.4	Axial sensitivity range (focal zone).....	48
8.9.5	Lateral sensitivity range (focal width).....	49
8.10	Beam parameters for angle-beam dual-transducer contact probes.....	50
8.10.1	General.....	50
8.10.2	Index point.....	50
8.10.3	Beam angle and profiles.....	50
8.10.4	Wedge delay path.....	51
8.10.5	Distance to sensitivity maximum (focal distance).....	51
8.10.6	Axial sensitivity range (length of the focal zone).....	51
8.10.7	Lateral sensitivity range (focal width).....	51
8.11	Crosstalk.....	52
8.11.1	Procedure.....	52
8.11.2	Acceptance criterion.....	52
Annex A (normative) Calculation of the near field length of non-focusing probes.....		53
Annex B (informative) Calibration block for angle-beam probes.....		56
Annex C (informative) Determination of delay line and wedge delays.....		60
Bibliography.....		61